VE320 Intro to Semiconductor Devices Summer 2022 — Problem Set 3

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Exercise 3.1

The thermal equilibrium hole concentration in silicon at T = 300 K is $p_0 = 2 \times 10^5 \text{ cm}^{-3}$. Determine the thermal-equilibrium electron concentration. Is the material n type or p type?

Exercise 3.2

In silicon at T=300 K, it is found that $N_a=7\times 10^{15}$ cm⁻³ and $p_0=2\times 10^4$ cm⁻³.

- (a) Is the material n type or p type?
- (b) What are the majority and minority carrier concentrations?
- (c) What must be the concentration of donor impurities?

Exercise 3.3

A silicon device is doped with donor impurity atoms at a concentration of 10^{15} cm⁻³. For the device to operate properly, the intrinsic carriers must contribute no more than 5 percent to the total electron concentration.

- (a) What is the maximum temperature that the device may operate?
- (b) What is the change in $E_c E_F$ from the T = 300 K value to the maximum temperature value determined in part (a).
 - (c) Is the Fermi level closer or further from the intrinsic value at the higher temperature?

Exercise 3.4

Silicon is doped at $N_d = 10^{15} \text{ cm}^{-3}$ and $N_a = 0$.

- (a) Plot the concentration of electrons versus temperature over the range 300 $\leq T \leq$ 600 K.
- (b) Calculate the temperature at which the electron concentration is equal to $1.1 \times 10^{15}~{\rm cm}^{-3}$.

Exercise 3.5

GaAs at $T=300~\mathrm{K}$ is doped with donor impurity atoms at a concentration of $7\times10^{15}~\mathrm{cm^{-3}}$. Additional impurity atoms are to be added such that the Fermi level is $0.55\mathrm{eV}$ above the intrinsic Fermi level. Determine the type (donor or acceptor) and concentration of impurity atoms to be added.

Exercise 3.6

A compensated p-type silicon material at $T=300~\rm K$ has impurity doping concentrations of $N_a=2.8\times 10^{17}~\rm cm^{-3}$ and $N_d=8\times 10^{16}~\rm cm^{-3}$. Determine the

- (a) hole mobility
- (b) conductivity
- (c) resistivity

Exercise 3.7

Consider a semiconductor that is uniformly doped with $N_d=10^{14}~\rm cm^{-3}$ and $N_a=0$, with an applied electric field of E = 100 V/cm. Assume that $\mu_n=1000~\rm cm^2/V\cdot s$ and $\mu_p=0$. Also assume the following parameters:

$$N_c = 2 \times 10^{19} (T/300)^{3/2} \text{ cm}^{-3}$$

 $N_v = 1 \times 10^{19} (T/300)^{3/2} \text{ cm}^{-3}$
 $E_g = 1.10 \text{eV}$

- (a) Calculate the electric-current density at $T=300~\mathrm{K}.$
- (b) At what temperature will this current increase by 5 percent? (Assume the mobilities are independent of temperature.)

Reference

1. Neamen, Donald A. Semiconductor physics and devices: basic principles. McGrawhill, 2003.